Product Preview

N-Channel Power MOSFET 600 V, 4.8 Ω

Features

- Low ON Resistance
- Low Gate Charge
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

| Rating | Symbol | Тур | Unit |
|--|-----------------------------------|-----------------|------|
| Drain-to-Source Voltage | V_{DSS} | 600 | V |
| Continuous Drain Current $R_{\theta JC}$ | I _D | 2.4 (Note 1) | Α |
| Continuous Drain Current $R_{\theta JC} T_A = 100^{\circ}C$ | I _D | 1.6 (Note 1) | Α |
| Pulsed Drain Current, V _{GS} @ 10 V | I _{DM} | 10 (Note 1) | Α |
| Power Dissipation $R_{\theta JC}$ | P_{D} | 24 | W |
| Gate-to-Source Voltage | V _{GS} | 30 | V |
| Single Pulse Avalanche Energy, I _D = 2.4 A | E _{AS} | 120 | mJ |
| ESD (HBM) (JESD 22-A114) | V _{esd} | 2500 | V |
| RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 14) | V _{ISO} | 4500 | V |
| Peak Diode Recovery | dv/dt | 4.5 (Note 2) | V/ns |
| Continuous Source Current (Body Diode) | Is | 2.4 | Α |
| Maximum Temperature for Soldering Leads | TL | 260 | °C |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | -55 to 150 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Limited by maximum junction temperature
- 2. $I_{SD} = 2.4 \text{ Å}$, $di/dt \le 100 \text{ A/}\mu\text{s}$, $V_{DD} \le BV_{DSS}$, $T_J = +150 ^{\circ}\text{C}$

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.



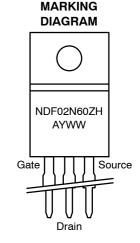
ON Semiconductor®

http://onsemi.com

| V _{DSS} | R _{DS(ON)} (MAX) @ 1 A |
|------------------|---------------------------------|
| 600 V | 4.8 Ω |



TO-220FP CASE 221AH

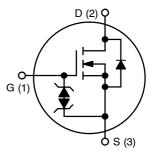


A = Location Code Y = Year

WW = Work Week

H = Halogen Free Package

N-Channel



ORDERING INFORMATION

| Device | Package | Shipping |
|------------|----------|-------------------------------------|
| NDF02N60ZH | TO-220FP | 50 Units / Rail (In Development) |

THERMAL RESISTANCE

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case (Drain) | $R_{\theta JC}$ | 5.2 | °C/W |
| Junction-to-Ambient Steady State (Note 3) | $R_{\theta JA}$ | 51 | |

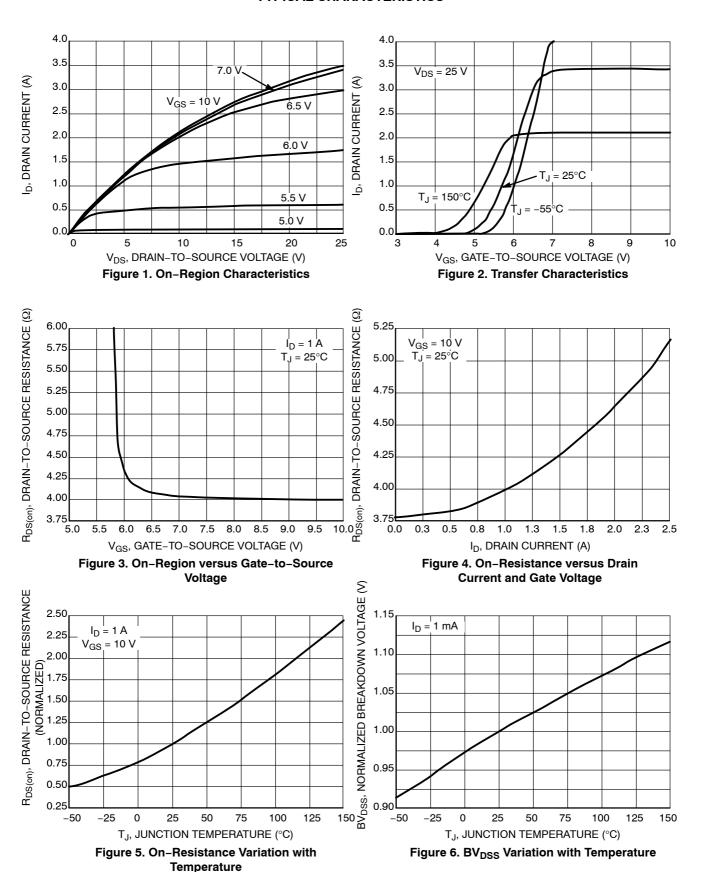
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Characteristic | Test Conditions | | Symbol | Min | Тур | Max | Unit |
|--|--|------------|---------------------------------|-----|------|-----|------|
| OFF CHARACTERISTICS | | | | | • | • | |
| Drain-to-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$ | | BV _{DSS} | 600 | | | V |
| Breakdown Voltage Temperature Coefficient | Reference to 25°C, I _D = 1 mA | | $\Delta BV_{DSS}/ \Delta T_{J}$ | | 0.6 | | V/°C |
| Drain-to-Source Leakage Current | V _{DS} = 600 V, V _{GS} = 0 V | 25°C | I _{DSS} | | | 1 | μΑ |
| | | 150°C | | | | 50 | |
| Gate-to-Source Forward Leakage | V _{GS} = ±20 V | • | I _{GSS} | | | ±10 | μΑ |
| ON CHARACTERISTICS (Note 5) | | | | | - | • | |
| Static Drain-to-Source On-Resistance | $V_{GS} = 10 \text{ V}, I_D = 1.0 \text{ A}$ | 4 | R _{DS(on)} | | 4.0 | 4.8 | Ω |
| Gate Threshold Voltage | V _{DS} = V _{GS} , I _D = 50 μ | A | V _{GS(th)} | 3.0 | | 4.5 | V |
| Forward Transconductance | V _{DS} = 15 V, I _D = 1.2 A | 4 | 9FS | | 1.7 | | S |
| DYNAMIC CHARACTERISTICS | | | | | | | |
| Input Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz | | C _{iss} | | 274 | | pF |
| Output Capacitance | | | C _{oss} | | 34 | | |
| Reverse Transfer Capacitance | | | C _{rss} | | 7.0 | | |
| Total Gate Charge | | | Q_g | | 10.1 | | nC |
| Gate-to-Source Charge | $V_{DD} = 300 \text{ V}, I_D = 2.4 \text{ A}, V_{GS} = 10 \text{ V}$ | | Q _{gs} | | 2.4 | | |
| Gate-to-Drain ("Miller") Charge | | | Q _{gd} | | 5.3 | | |
| Plateau Voltage | | | V _{GP} | | 6.4 | | V |
| Gate Resistance | | | R_{g} | | 4.9 | | Ω |
| RESISTIVE SWITCHING CHARACTERI | STICS | | | | - | • | |
| Turn-On Delay Time | | | t _{d(on)} | | 9.0 | | ns |
| Rise Time | V_{DD} = 300 V, I_{D} = 2.4 A, V_{GS} = 10 V, R_{G} = 5 Ω | | t _r | | 7.0 | | |
| Turn-Off Delay Time | | | t _{d(off)} | | 15 | | |
| Fall Time | | | t _f | | 7.0 | | |
| SOURCE-DRAIN DIODE CHARACTER | ISTICS (T _C = 25°C unless oth | erwise not | ed) | | | | |
| Diode Forward Voltage | I _S = 2.4 A, V _{GS} = 0 V | | V_{SD} | | | 1.6 | V |
| Reverse Recovery Time | $V_{GS} = 0 \text{ V}, V_{DD} = 30 \text{ V}$ $I_{S} = 2.4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ | | t _{rr} | | 240 | | ns |
| Reverse Recovery Charge | | | Q_{rr} | | 0.7 | | μС |
| | | | | | | | |

^{5.} Pulse Width \leq 380 μ s, Duty Cycle \leq 2%.

Insertion mounted
 Surface mounted on FR4 board using 1" sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces).

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

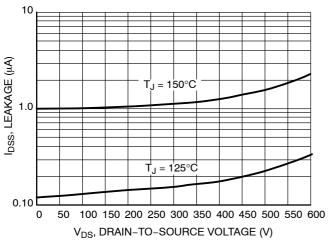


Figure 7. Drain-to-Source Leakage Current versus Voltage

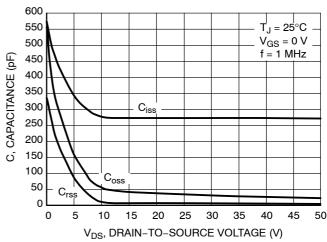


Figure 8. Capacitance Variation

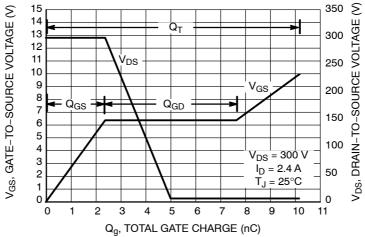


Figure 9. Gate-to-Source Voltage and Drain-to-Source Voltage versus Total Charge

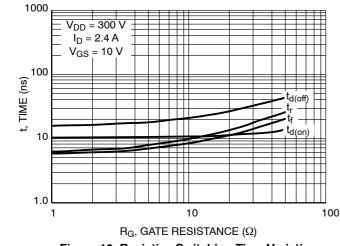


Figure 10. Resistive Switching Time Variation versus Gate Resistance

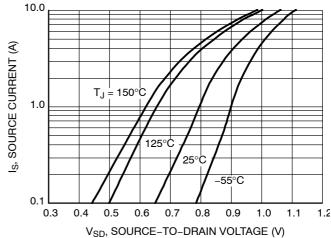


Figure 11. Diode Forward Voltage versus Current

TYPICAL CHARACTERISTICS

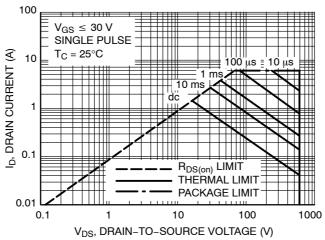


Figure 12. Maximum Rated Forward Biased Safe Operating Area

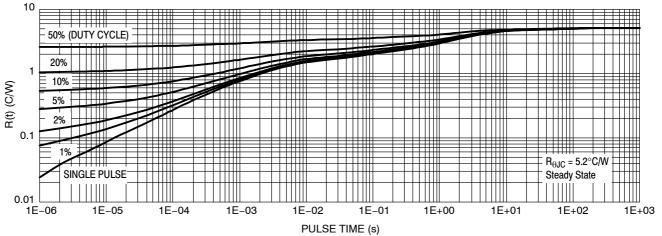


Figure 13. Thermal Impedance (Junction-to-Case)

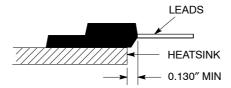


Figure 14. Isolation Test Diagram

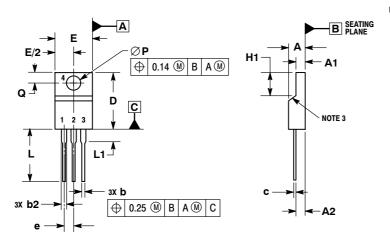
Measurement made between leads and heatsink with all leads shorted together.

*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

TO-220 FULLPACK, 3-LEAD

CASE 221AH-01 **ISSUE O**



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

- THE JUNE DIMENSION: MILLIMETERS.
 CONTROLLING DIMENSION: MILLIMETERS.
 CONTOUR UNCONTROLLED IN THIS AREA.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH
 AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY.
- 5. DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00.

| | MILLIMETERS | | | |
|-----|-------------|-------|--|--|
| DIM | MIN | MAX | | |
| Α | 4.30 | 4.70 | | |
| A1 | 2.50 | 2.90 | | |
| A2 | 2.50 | 2.70 | | |
| b | 0.54 | 0.84 | | |
| b2 | 1.10 | 1.40 | | |
| С | 0.49 | 0.79 | | |
| D | 14.22 | 15.88 | | |
| Е | 9.65 | 10.67 | | |
| е | 2.54 BSC | | | |
| H1 | 5.97 | 6.48 | | |
| L | 12.70 | 14.73 | | |
| L1 | | 2.80 | | |
| Р | 3.00 | 3.40 | | |
| Q | 2.80 | 3.20 | | |

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